Notice of References Cited Application/Control No. 10/563,441 Examiner Louis K. Huynh Applicant(s)/Patent Under Reexamination . RIETJENS ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,909,582	09-1975	Bowen, William Edmund	219/121.69
*	В	US-4,049,945	09-1977	Ehlscheid et al.	219/121.67
*	С	US-4,160,894	07-1979	Stemmler et al.	219/121.67
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Ι	US-			·
	1	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	•				
	0					
	Р					
	α					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
4	V	
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.